onsemi

Silicon Carbide (SiC) Module – EliteSiC, 40 mohm SiC M1 MOSFET, 1200 V + 40 A, 1200 V SiC Diode, Two Channel Full SiC Boost, Q0 Package



Description

The NXH40B120MNQ0SNG is a power module containing a dual boost stage. The integrated SiC MOSFETs and SiC Diodes provide lower conduction losses and switching losses, enabling designers to achieve high efficiency and superior reliability.

Features

- 1200 V, 40 mΩ SiC MOSFETs
- Low Reverse Recovery and Fast Switching SiC Diodes
- 1200 V Bypass and Anti-parallel Diodes
- Low Inductive Layout
- Solder Pins
- Thermistor
- These Device is Pb-Free, Halogen Free and is RoHS Compliant

Typical Applications

- Solar Inverter
- Uninterruptible Power Supplies

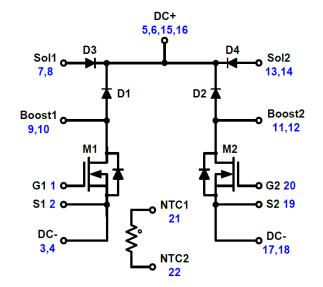
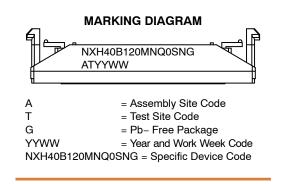
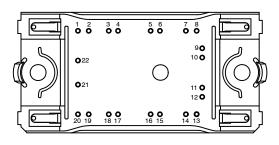


Figure 1. NXH40B120MNQ0SNG Schematic Diagram

Q0BOOST CASE 180AJ SOLDER PINS



PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 4 of this data sheet.

DATA SHEET www.onsemi.com

ABSOLUTE MAXIMUM RATINGS (Note 1) (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
BOOST MOSFET			
Drain-Source Voltage	V _{DS}	1200	V
Gate-Source Voltage	V _{GS}	-15/+25	V
Continuous Drain Current (@ V_{GS} = 20 V, T _C = 80°C)	۱ _D	38	А
Pulsed Drain Current @ T_{C} = 80°C (T_{J} = 175°C)	I _{D(Pulse)}	114	А
Maximum Power Dissipation @ T_{C} = 80°C (T_{J} = 175°C)	P _{tot}	118	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	175	°C
BOOST DIODE			
Peak Repetitive Reverse Voltage	V _{RRM}	1200	V
Continuous Forward Current @ T _C = 80°C	١ _F	45	А
Repetitive Peak Forward Current (T_J = 175°C, tp limited by T_{Jmax})	I _{FRM}	135	А
Maximum Power Dissipation @ T_{C} = 80°C (T_{J} = 175°C)	P _{tot}	118	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	175	°C
BYPASS DIODE			
Peak Repetitive Reverse Voltage	V _{RRM}	1200	V
Continuous Forward Current @ $T_C = 80^{\circ}C (T_J = 150^{\circ}C)$	١ _F	50	А
Repetitive Peak Forward Current ($T_J = 150^{\circ}C$, t_p limited by T_{Jmax})	I _{FRM}	150	А
Power Dissipation Per Diode @ T_C = 80°C (T_J = 175 °C)	P _{tot}	61	W
Minimum Operating Junction Temperature	T _{JMIN}	-40	°C
Maximum Operating Junction Temperature	T _{JMAX}	150	°C
THERMAL PROPERTIES			
Storage Temperature Range	T _{stg}	-40 to 125	°C
INSULATION PROPERTIES			
Isolation Test Voltage, t = 1 sec, 60 Hz	V _{is}	3000	V _{RMS}
Creepage Distance		12.7	mm

should not be assumed, damage may occur and reliability may be affected.
 Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

RECOMMENDED OPERATING RANGES

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	TJ	-40	(T _{Jmax} –25)	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

Parameter	Test Conditions	Test Conditions Symbol		Тур	Max	Unit
BOOST MOSFET CHARACTERISTICS						
Zero Gate Voltage Drain Current	V_{GS} = 0 V, V_{DS} = 1200 V, T_{J} = 25°C	I _{DSS}	-	_	200	μΑ
Static Drain-to-Source On Resistance	V_{GS} = 20 V, I _D = 40 A, T _J = 25°C	R _{DS(on)}	-	40	55	mΩ
	$\label{eq:VGS} \begin{array}{l} V_{GS} = 20 \text{ V}, \text{ I}_D = 40 \text{ A}, \\ T_J = 175^\circ\text{C} \end{array}$		-	60	-	
Gate-Source Leakage Current	$V_{GS} = -15 \text{ V} / +25 \text{ V},$ $V_{DS} = 0 \text{ V}$	I _{GSS}	-	-	1	μΑ
Turn-on Delay Time	$T_{J} = 25^{\circ}C, V_{DS} = 700 V,$	t _{d(on)}	-	17	_	ns
Rise Time	I_D = 40 A, V _{GS} = -5 V / 20 V, R _G = 4.7 Ω	t _r	-	7.5	_	
Turn-off Delay Time		t _{d(off)}	-	43.8	_	
Fall Time		t _f	-	17	_	
Turn-on Switching Loss per Pulse		Eon	-	255	_	μJ
Turn-off Switching Loss per Pulse		E _{off}	-	125.5	-	μJ
Turn-on Delay Time	$T_{J} = 125^{\circ}C, V_{DS} = 700 V,$	t _{d(on)}	-	15.8	_	ns
Rise Time	I_D = 40 A, V _{GS} = -5 V / 20 V, R _G = 4.7 Ω	tr	-	7	_	
Turn-off Delay Time		t _{d(off)}	-	46.5	_	
Fall Time		t _f	-	13.5	_	
Turn-on Switching Loss per Pulse		E _{on}	-	383	_	μJ
Turn-off Switching Loss per Pulse		E _{off}	-	108.5	-	μJ
Input Capacitance	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz	C _{ies}	-	3227	_	pF
Output Capacitance		C _{oes}	-	829	_	pF
Reverse Transfer Capacitance		C _{res}	-	19	_	pF
Total Gate Charge	$V_{DS} = 600 \text{ V}, \text{ I}_{D} = 20 \text{ A}, V_{GS} = 20 \text{ V}, -15 \text{ V}$	Qg	-	146.72	-	nC
Thermal Resistance - Chip-to-Case	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJC}	-	0.81	_	K/W
Thermal Resistance - Chip-to-Heatsink	$\lambda = 2.9 \text{ W/mK}$	R _{thJH}	-	1.26	_	K/W
BOOST DIODE CHARACTERISTICS						-
Diode Reverse Leakage Current	V _R = 1200 V	I _R	-	-	400	μΑ
Diode Forward Voltage	$I_{F} = 40 \text{ A}, \text{ T}_{J} = 25^{\circ}\text{C}$	V _F	_	1.50	1.75	V
	I _F = 40 A, T _J = 175°C		-	2.17	-	
Reverse Recovery Time	T _J = 25°C V _{DS} = 700 V, I _D = 40 A	t _{rr}	-	16.7	-	ns
Reverse Recovery Charge	$V_{GS} = -5 V / 20 V,$ $R_G = 4.7 \Omega$	Q _{rr}	-	329.6	-	nC
Peak Reverse Recovery Current	110 - 7.7 22	I _{RRM}	-	34.3	—	А
Peak Rate of Fall of Recovery Current		di/dt	-	6684	_	A/μs
Reverse Recovery Energy		Err	-	176.6	-	μJ

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted) (continued)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
BOOST DIODE CHARACTERISTICS				-		-
Reverse Recovery Time	$T_{\rm J} = 125^{\circ}C$	t _{rr}	-	16.9	_	ns
Reverse Recovery Charge	$V_{DS} = 700 \text{ V}, \text{ I}_{D} = 40 \text{ A}$ $V_{GS} = -5 \text{ V} / 20 \text{ V},$	Q _{rr}	-	361	_	nC
Peak Reverse Recovery Current	$R_{G} = 4.7 \Omega$	I _{RRM}	-	37	_	А
Peak Rate of Fall of Recovery Current		di/dt	-	8067	_	A/μs
Reverse Recovery Energy		E _{rr}	-	209.1	-	μJ
Thermal Resistance - Chip-to-Case	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJC}	-	0.70	_	K/W
Thermal Resistance - Chip-to-Heatsink	$\lambda = 2.9 \text{ W/mK}$	R _{thJH}	_	1.14	-	K/W

BYPASS DIODE CHARACTERISTICS

Diode Reverse Leakage Current	V_{R} = 1200 V, T_{J} = 25°C	I _R	-	-	250	μΑ
Diode Forward Voltage	$I_F = 50 \text{ A}, \text{ T}_J = 25^{\circ}\text{C}$	V _F	-	1.11	1.3	V
	I _F = 50 A, T _J = 150°C		-	1.00	-	
Thermal Resistance - Chip-to-Case	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJC}	-	1.15	_	K/W
Thermal Resistance - Chip-to-Heatsink	$\lambda = 2.9 \text{ W/mK}$	R _{thJC}	-	1.75	_	K/W

THERMISTOR CHARACTERISTICS

Nominal Resistance		R ₂₅	-	22	-	kΩ
Nominal Resistance	T = 100°C	R ₁₀₀	-	1486	-	Ω
Deviation of R25		$\Delta R/R$	-5	-	5	%
Power Dissipation		PD	-	200	-	mW
Power Dissipation Constant			-	2	-	mW/K
B-value	B (25/50), tolerance \pm 3%		-	3950	-	К
B-value	B (25/100), tolerance ±3%		-	3998	_	К

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

PACKAGE MARKING AND ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH40B120MNQ0SNG	NXH40B120MNQ0SNG	Q0PACK – Case 180AJ (Pb-Free and Halide-Free Solder Pins)	24 Units / Blister Tray

TYPICAL CHARACTERISTICS – MOSFET, BOOST DIODE AND BYPASS DIODE

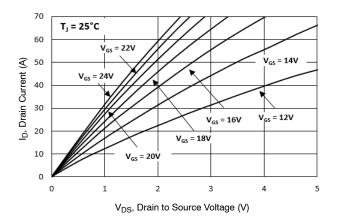


Figure 2. MOSFET on Region Characteristics

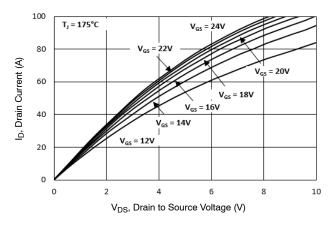


Figure 3. MOSFET on Region Characteristics

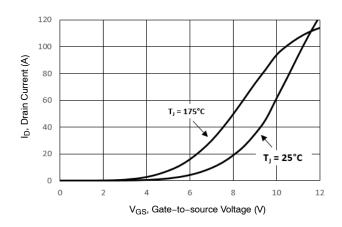


Figure 4. MOSFET Transfer Characteristics

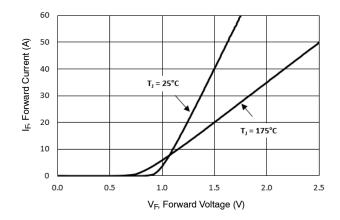


Figure 5. Boost Diode Forward Characteristics

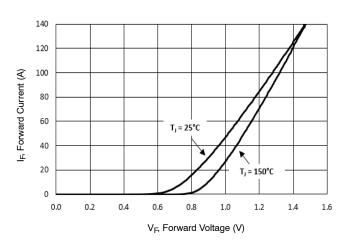


Figure 6. Bypass Diode Forward Characteristics

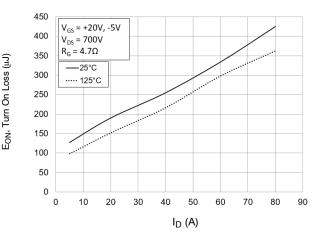
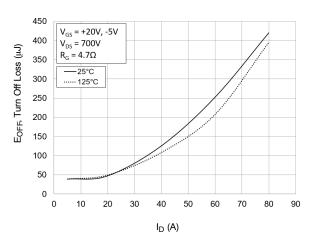


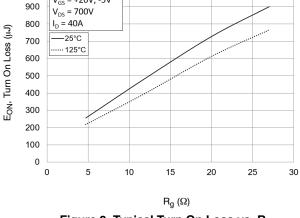
Figure 7. Typical Turn On Loss vs. ID

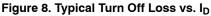
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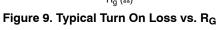
V_{GS} = +20V, -5V

TYPICAL CHARACTERISTICS - MOSFET, BOOST DIODE AND BYPASS DIODE (continued)









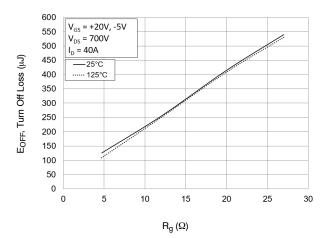
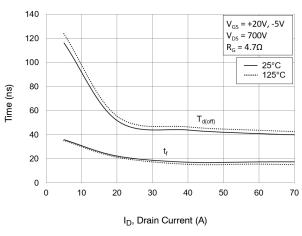
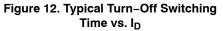
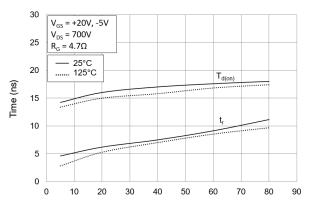


Figure 10. Typical Turn Off Loss vs. R_G

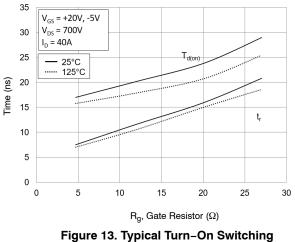


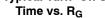


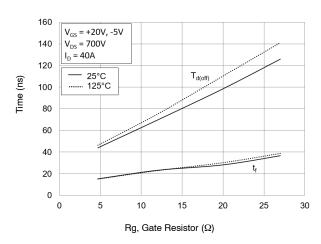


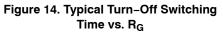
I_D, Drain Current (A)

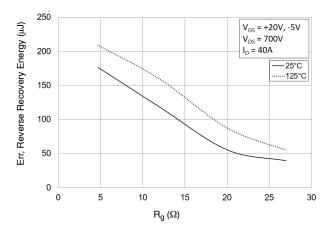
Figure 11. Typical Turn-On Switching Time vs. ID



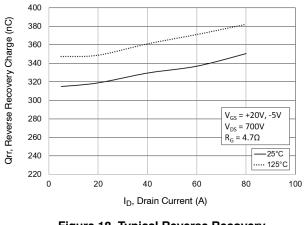














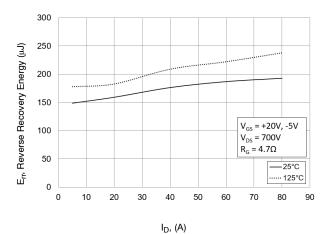


Figure 15. Typical Reverse Recovery Energy Loss vs. I_D

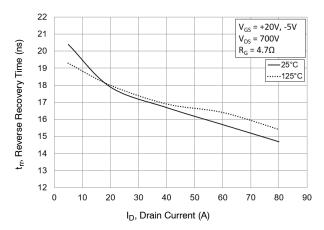
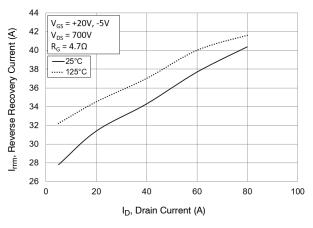


Figure 17. Typical Reverse Recovery Time vs. I_D





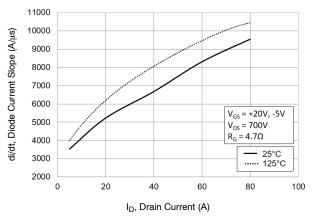


Figure 20. Typical di/dt Current Slope vs. ID

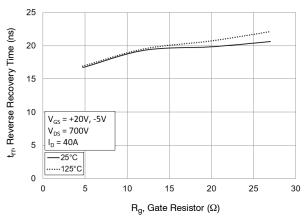
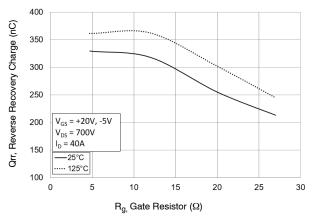


Figure 21. Typical Reverse Recovery Time vs. R_G





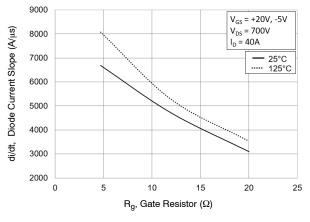


Figure 24. Typical di/dt vs. R_{G}

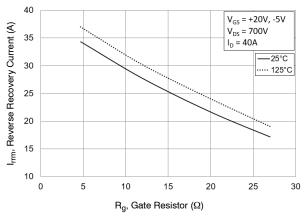
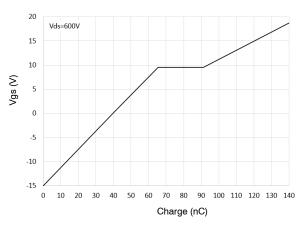
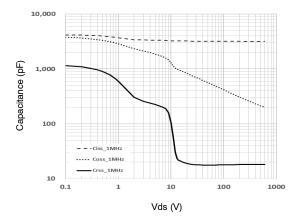
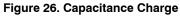


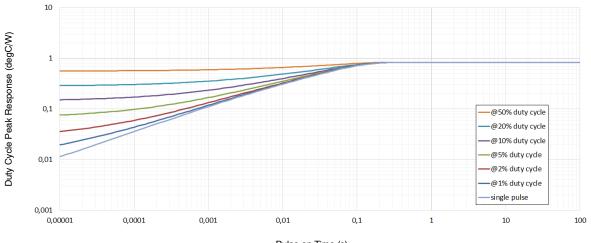
Figure 23. Typical Reverse Recovery Peak Current vs. R_G





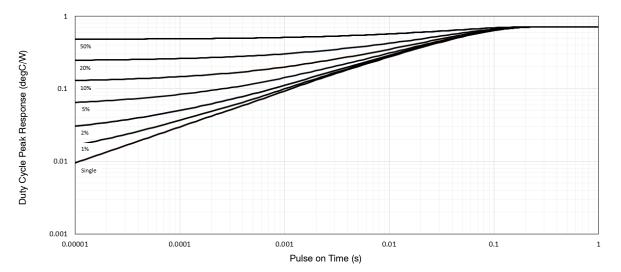






Pulse on Time (s)

Figure 27. Mosfet Transient Thermal Impedance





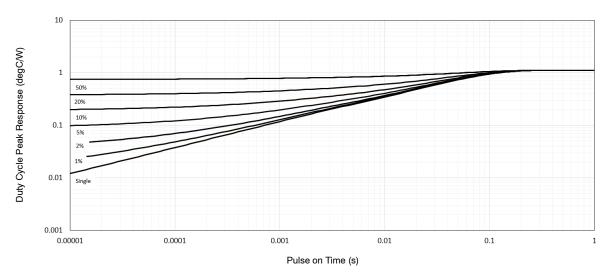


Figure 29. Bypass Diode Transient Thermal Impedance

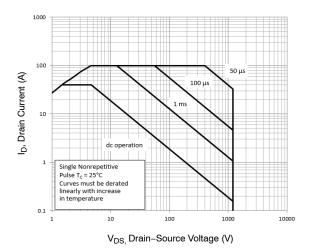


Figure 30. FBSOA for MOSFET

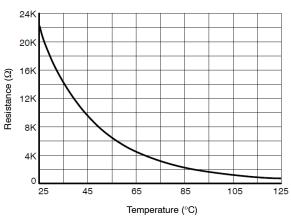


Figure 32. Thermistor Characteristics

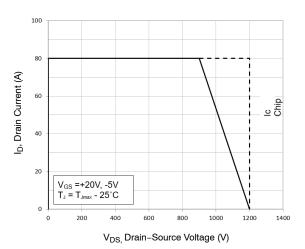
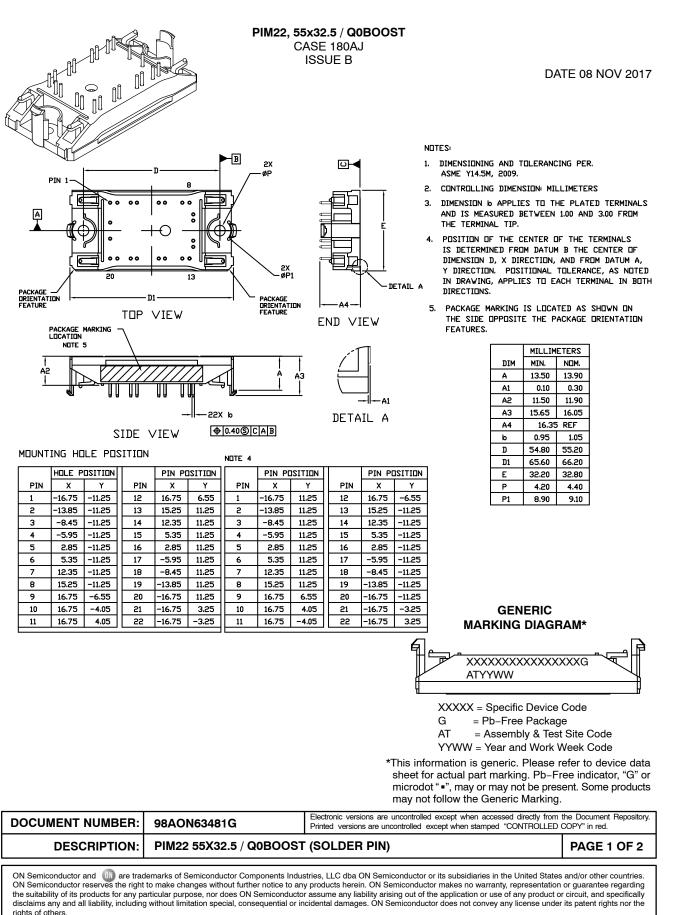


Figure 31. RBSOA for MOSFET

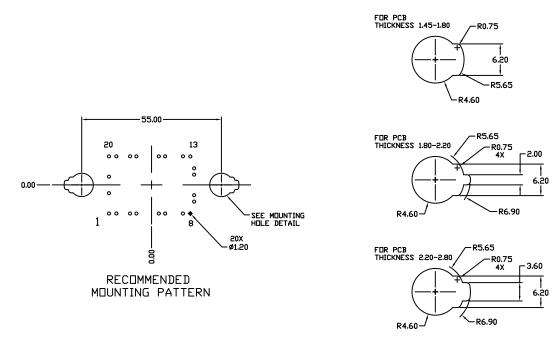
MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS





PIM22, 55x32.5 / Q0BOOST CASE 180AJ ISSUE B

DATE 08 NOV 2017



MOUNTING HOLE DETAIL

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